



fastPACK 0 SiC

1200 V / 75 mΩ

Features

- Compact and low inductive design
- High frequency SiC MOSFET
- High power low inductive package
- Integrated DC-capacitor
- Integrated NTC

Target applications

- Charging Stations
- Power Supply

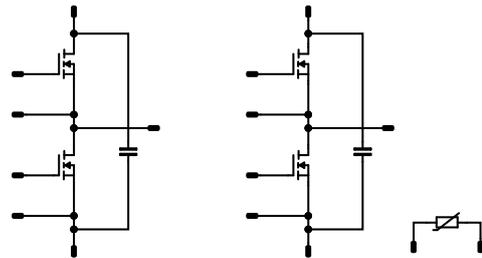
Types

- 10-PZ124PA075ME03-L627F28Y

flow 0 12 mm housing



Schematic





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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Half-Bridge Switch				
Drain-source voltage	V_{DSS}		1200	V
Drain current (DC current)	I_D	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	20	A
Peak drain current	I_{DM}	t_p limited by T_{jmax}	80	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	52	W
Gate-source voltage	V_{GSS}		-4 / 15	V
		dynamic	-8 / 19	
Maximum Junction Temperature	T_{jmax}		175	°C

Capacitor (DC)

Maximum DC voltage	V_{MAX}		1000	V
Operation Temperature	T_{op}		0 ... 125	°C

Module Properties

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{jop}		-40...+($T_{jmax} - 25$)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC Test Voltage* $t_p = 2\text{ s}$	6000	V
Isolation voltage	V_{isol}	AC Voltage $t_p = 1\text{ min}$	2500	V
Creepage distance			min. 12,7	mm
Clearance			9,15	mm
Comparative Tracking Index	CTI		≥ 200	

*100 % tested in production



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Half-Bridge Switch

Static

Drain-source on-state resistance	$r_{DS(on)}$		15		20	25 125 150		82 105 117	90 ⁽¹⁾	mΩ
Gate-source threshold voltage	$V_{GS(th)}$		0		0,005	25	1,7	2,5	4	V
Gate to Source Leakage Current	I_{GSS}		15	0		25		10	250	nA
Zero Gate Voltage Drain Current	I_{DSS}		0	1200		25		1	100	μA
Internal gate resistance	r_g							10,5		Ω
Gate charge	Q_g		-4/15	800	20	25		54		nC
Short-circuit input capacitance	C_{iss}	$f = 1$ Mhz	0	1000	0	25		1350		pF
Short-circuit output capacitance	C_{oss}							58		
Reverse transfer capacitance	C_{rss}							3		
Diode forward voltage	V_{SD}		0		10	25		4,5		V

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 3,4$ W/mK (PSX)						1,84		K/W
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10-PZ124PA075ME03-L627F28Y
datasheet

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		
Dynamic										
Turn-on delay time	$t_{d(on)}$					25 125 150		12,48 11,2 10,88		ns
Rise time	t_r	$R_{gon} = 8 \Omega$ $R_{goff} = 8 \Omega$				25 125 150		8,32 7,04 7,36		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		66,24 77,12 80,64		ns
Fall time	t_f					25 125 150		23,17 22,22 21,04		ns
Turn-on energy (per pulse)	E_{on}	$Q_{rFWD}=0,174 \mu C$ $Q_{tFWD}=0,249 \mu C$ $Q_{rFWD}=0,301 \mu C$	0/15	600	16	25 125 150		0,282 0,295 0,315		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,058 0,069 0,074		mWs
Peak recovery current	I_{RRM}					25 125 150		14,38 16,6 18,32		A
Reverse recovery time	t_{rr}					25 125 150		29,91 27,26 26,97		ns
Recovered charge	Q_r	$di/dt=1991 A/\mu s$ $di/dt=2360 A/\mu s$ $di/dt=2533 A/\mu s$				25 125 150		0,174 0,249 0,301		μC
Reverse recovered energy	E_{rec}					25 125 150		0,031 0,054 0,068		mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25 125 150		1936 500,51 1838		A/ μs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
		V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max		

Capacitor (DC)

Static

Capacitance	C	DC bias voltage = 0 V				25		2,2		nF
Tolerance							-5		5	%
Dissipation factor		$f = 1$ kHz				25		1,5		%

Thermistor

Static

Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$A_{R/R}$	$R_{100} = 1484 \Omega$				100	-5		5	%
Power dissipation	P							5		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ± 1 %						3962		K
B-value	$B_{(25/100)}$	Tol. ± 1 %						4000		K
Vincotech Thermistor Reference									I	

(1) Value at chip level

(2) Only valid with pre-applied Vincotech thermal interface material.

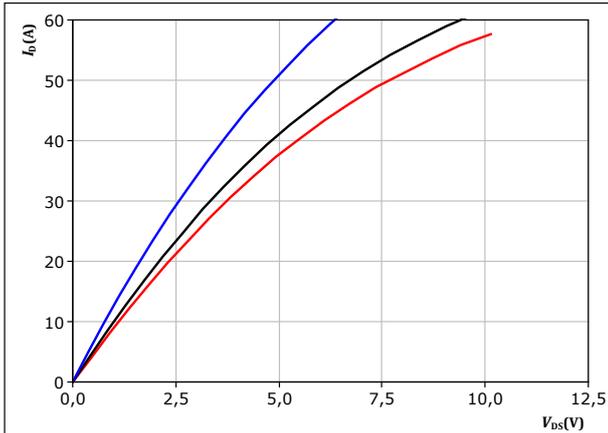


Half-Bridge Switch Characteristics

figure 1. MOSFET

Typical output characteristics

$$I_D = f(V_{DS})$$

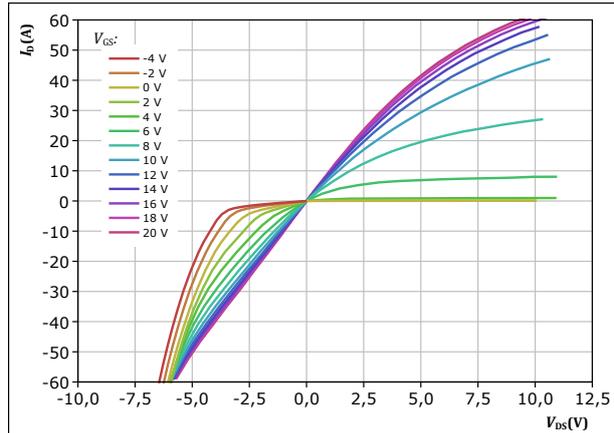


$t_p = 250 \mu s$
 $V_{GS} = 14 V$
 $T_j:$ 25 °C, 125 °C, 150 °C

figure 2. MOSFET

Typical output characteristics

$$I_D = f(V_{DS})$$

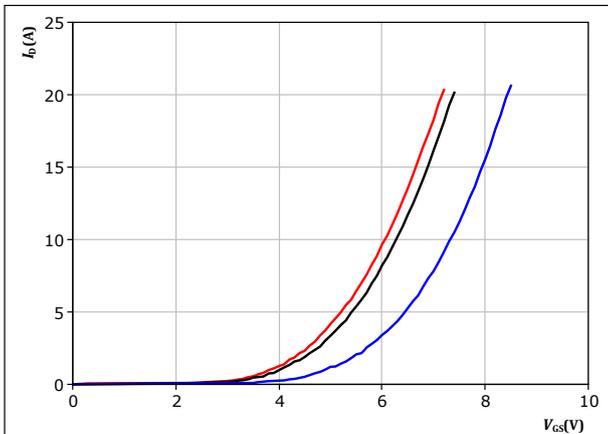


$t_p = 250 \mu s$
 $T_j = 150 \text{ } ^\circ\text{C}$
 V_{GS} from -4 V to 20 V in steps of 2 V

figure 3. MOSFET

Typical transfer characteristics

$$I_D = f(V_{GS})$$

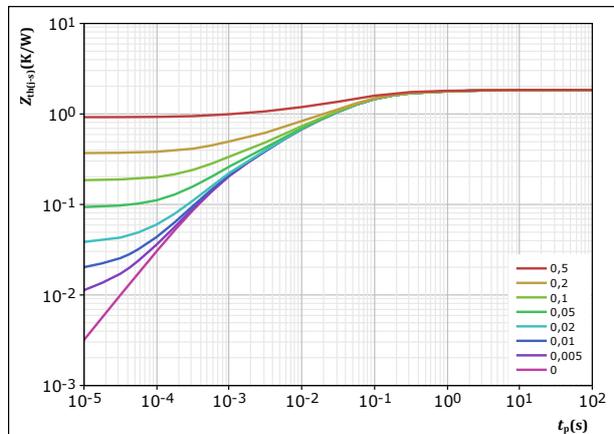


$t_p = 250 \mu s$
 $V_{DS} = 10 V$
 $T_j:$ 25 °C, 125 °C, 150 °C

figure 4. MOSFET

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 1,843 \text{ K/W}$
MOSFET thermal model values

R (K/W)	τ (s)
1,10E-01	1,89E+00
4,15E-01	1,55E-01
7,53E-01	3,96E-02
4,02E-01	6,20E-03
1,64E-01	7,03E-04

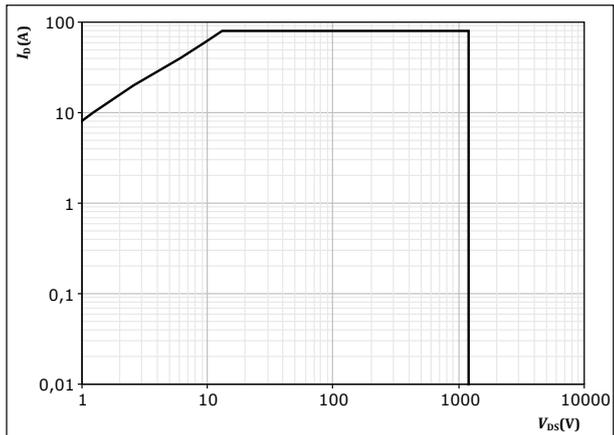


Half-Bridge Switch Characteristics

figure 5. MOSFET

Safe operating area

$$I_D = f(V_{DS})$$



$D =$ single pulse

$T_s = 80$ °C

$V_{GS} = 14$ V

$T_j = T_{jmax}$

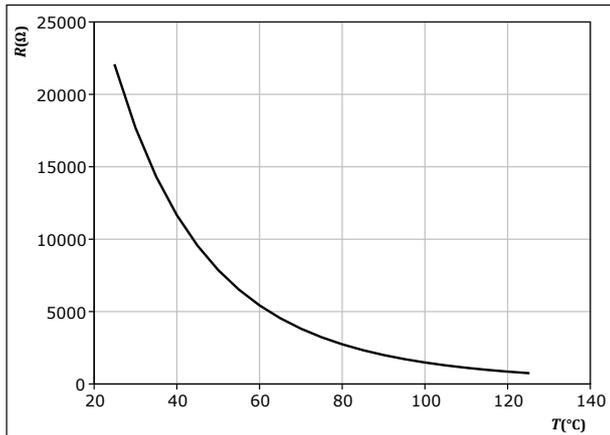


Thermistor Characteristics

figure 6. Thermistor

Typical NTC characteristic as function of temperature

$$R_T = f(T)$$

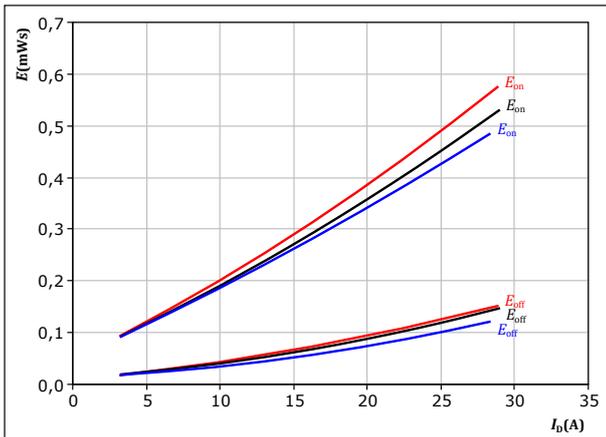




Half-Bridge Switching Characteristics

figure 7. MOSFET

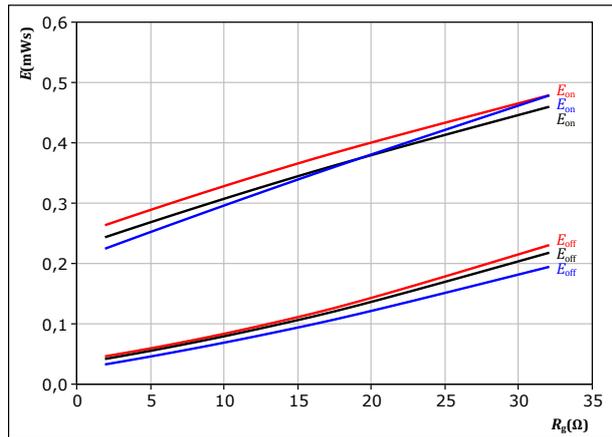
Typical switching energy losses as a function of drain current
 $E = f(I_D)$



With an inductive load at
 $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω
 $R_{goff} = 8$ Ω
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 8. MOSFET

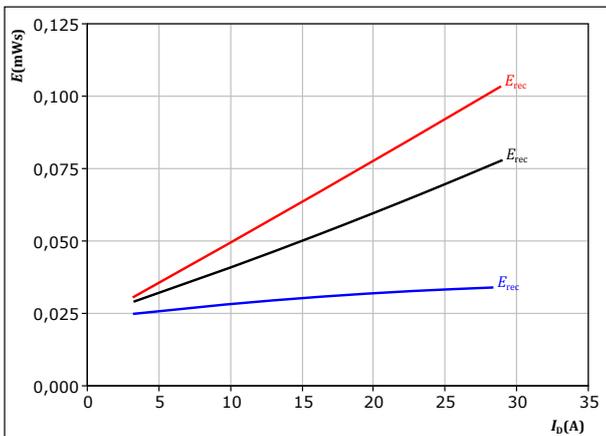
Typical switching energy losses as a function of gate resistor
 $E = f(R_g)$



With an inductive load at
 $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 9. MOSFET

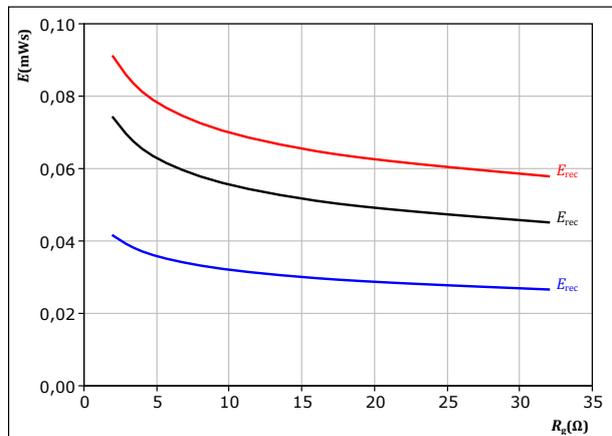
Typical reverse recovered energy loss as a function of drain current
 $E_{rec} = f(I_D)$



With an inductive load at
 $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 10. MOSFET

Typical reverse recovered energy loss as a function of gate resistor
 $E_{rec} = f(R_g)$



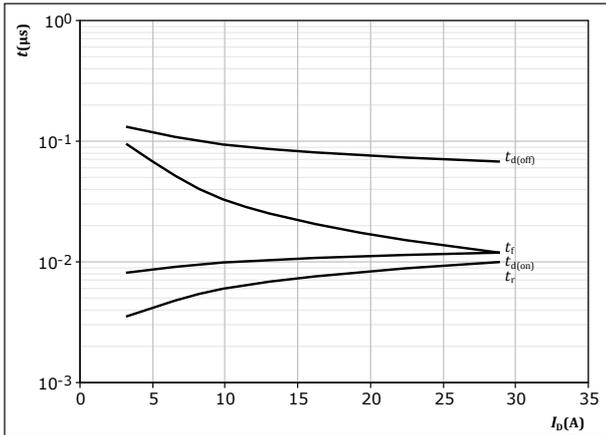
With an inductive load at
 $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)



Half-Bridge Switching Characteristics

figure 11. MOSFET

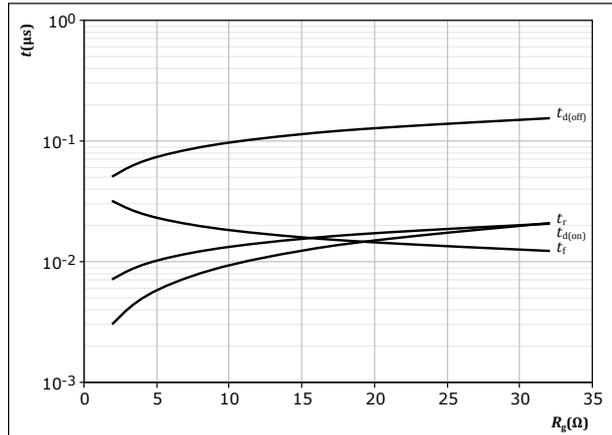
Typical switching times as a function of drain current
 $t = f(I_D)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{DS} = 600 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$
 $R_{goff} = 8 \text{ } \Omega$

figure 12. MOSFET

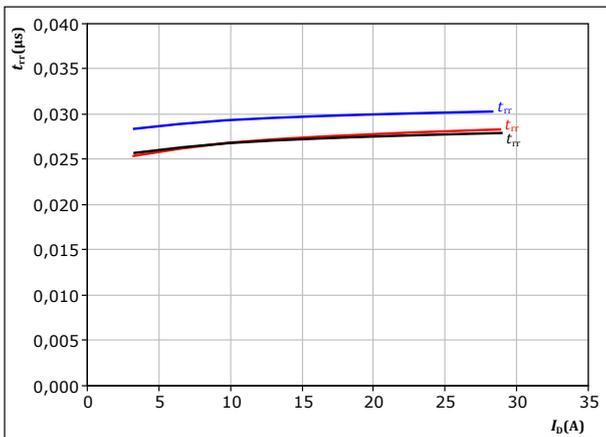
Typical switching times as a function of gate resistor
 $t = f(R_g)$



With an inductive load at
 $T_j = 150 \text{ }^\circ\text{C}$
 $V_{DS} = 600 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$

figure 13. MOSFET

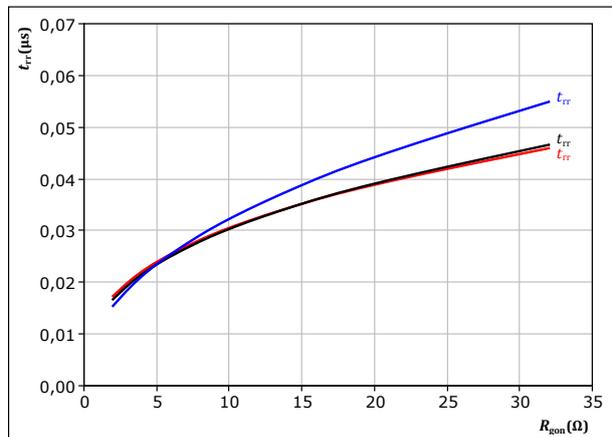
Typical reverse recovery time as a function of drain current
 $t_{rr} = f(I_D)$



At $V_{DS} = 600 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$
 $T_j: 25 \text{ }^\circ\text{C}$
 $125 \text{ }^\circ\text{C}$
 $150 \text{ }^\circ\text{C}$

figure 14. MOSFET

Typical reverse recovery time as a function of turn on gate resistor
 $t_{rr} = f(R_{gon})$



At $V_{DS} = 600 \text{ V}$
 $V_{GS} = 0/15 \text{ V}$
 $I_D = 16 \text{ A}$
 $T_j: 25 \text{ }^\circ\text{C}$
 $125 \text{ }^\circ\text{C}$
 $150 \text{ }^\circ\text{C}$

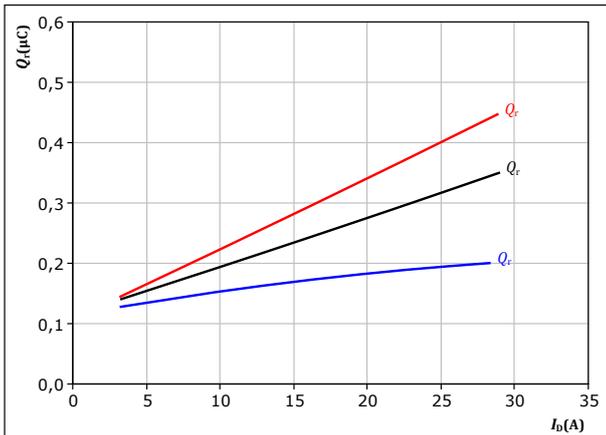


Half-Bridge Switching Characteristics

figure 15. MOSFET

Typical recovered charge as a function of drain current

$$Q_r = f(I_D)$$

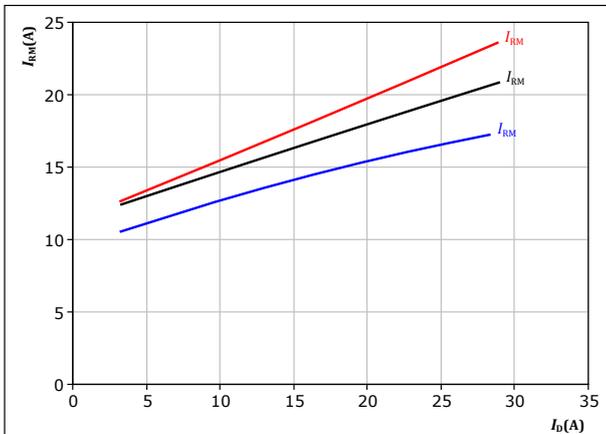


At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 17. MOSFET

Typical peak reverse recovery current as a function of drain current

$$I_{RM} = f(I_D)$$

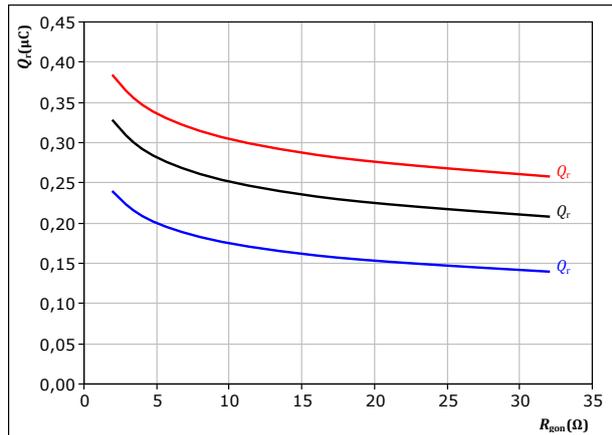


At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $R_{gon} = 8$ Ω
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 16. MOSFET

Typical recovered charge as a function of turn on gate resistor

$$Q_r = f(R_{gon})$$

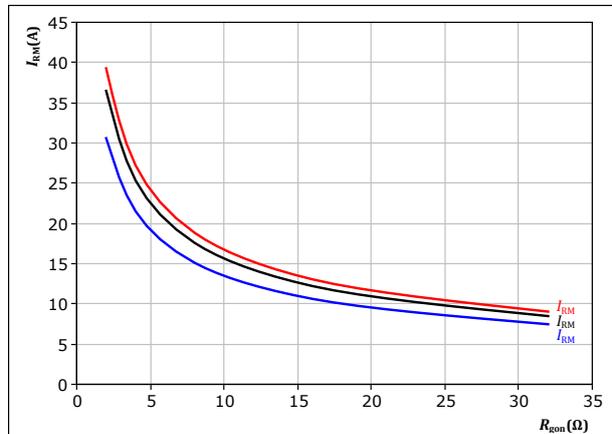


At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)

figure 18. MOSFET

Typical peak reverse recovery current as a function of turn on gate resistor

$$I_{RM} = f(R_{gon})$$



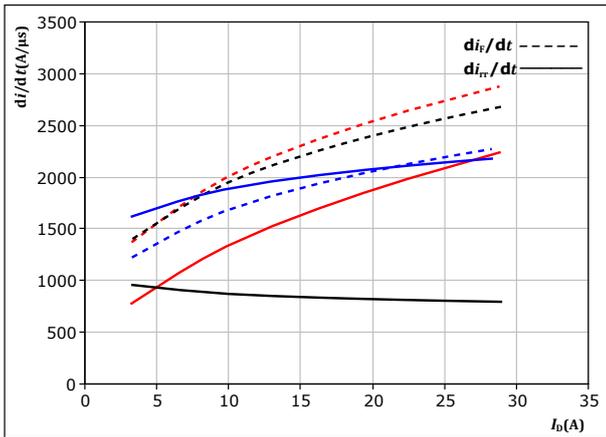
At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A
 T_j : 25 °C (blue), 125 °C (black), 150 °C (red)



Half-Bridge Switching Characteristics

figure 19. MOSFET

Typical rate of fall of forward and reverse recovery current as a function of drain current
 $di_f/dt, di_{rr}/dt = f(I_D)$

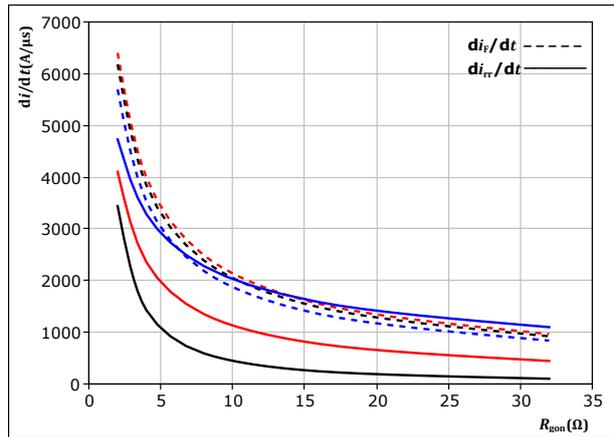


At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $R_{g\text{on}} = 8$ Ω

T_j : 25 °C
 125 °C
 150 °C

figure 20. MOSFET

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_{g\text{on}})$



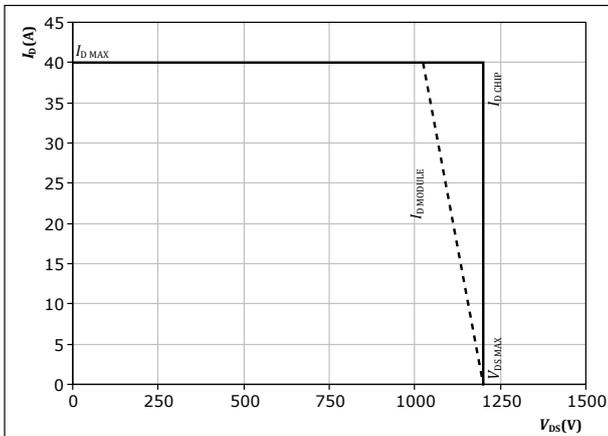
At $V_{DS} = 600$ V
 $V_{GS} = 0/15$ V
 $I_D = 16$ A

T_j : 25 °C
 125 °C
 150 °C

figure 21. MOSFET

Reverse bias safe operating area

$I_D = f(V_{DS})$



At $T_j = 150$ °C
 $R_{g\text{on}} = 8$ Ω
 $R_{g\text{off}} = 8$ Ω



Half-Bridge Switching Definitions

figure 22. MOSFET

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})

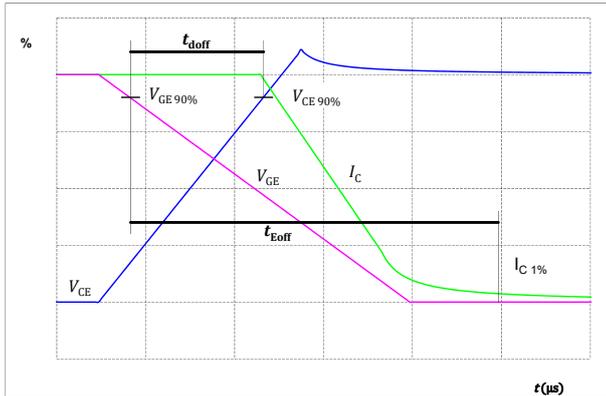


figure 23. MOSFET

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})

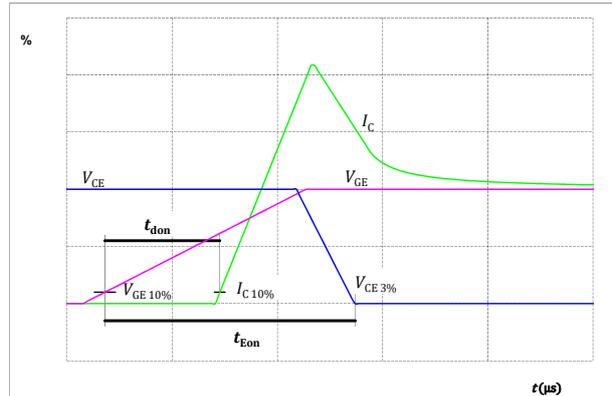


figure 24. MOSFET

Turn-off Switching Waveforms & definition of t_f

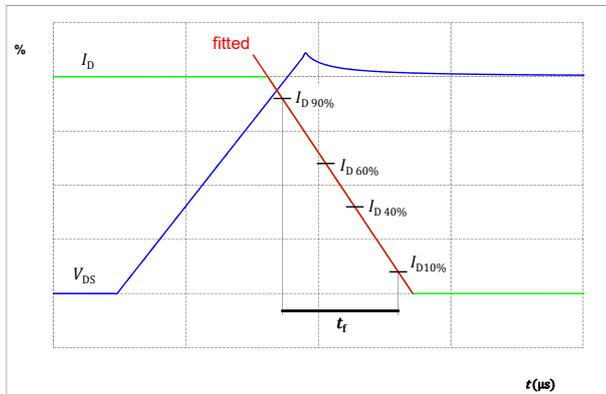
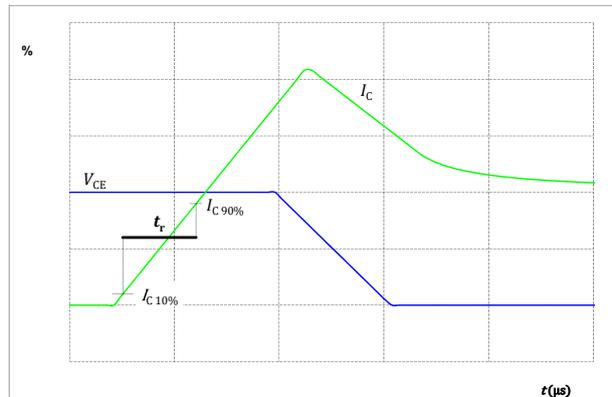


figure 25. MOSFET

Turn-on Switching Waveforms & definition of t_r





Half-Bridge Switching Definitions

figure 26. FWD

Turn-off Switching Waveforms & definition of t_{tr}

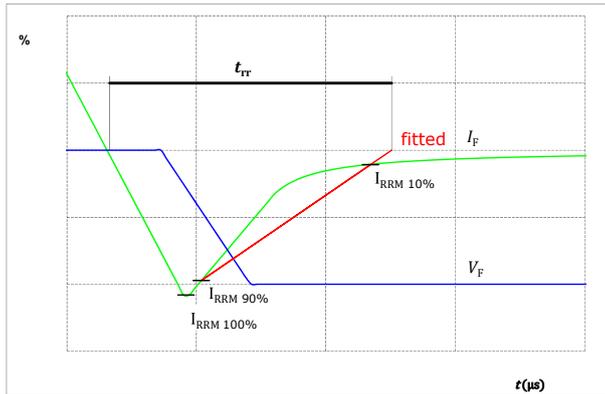


figure 27. FWD

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)

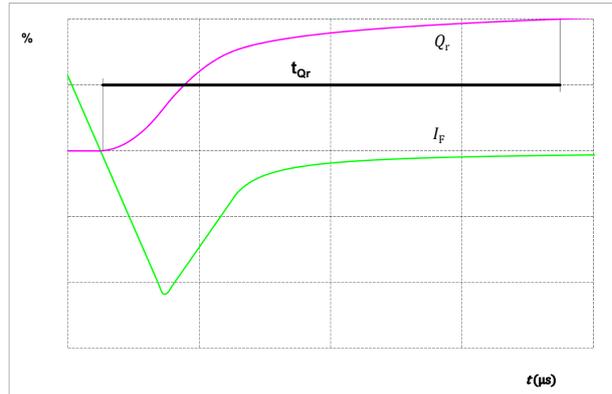
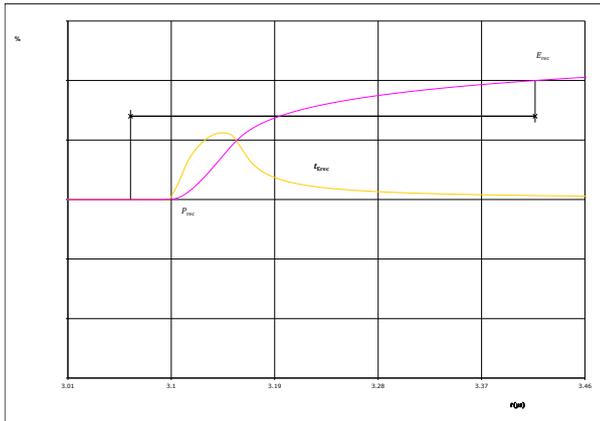


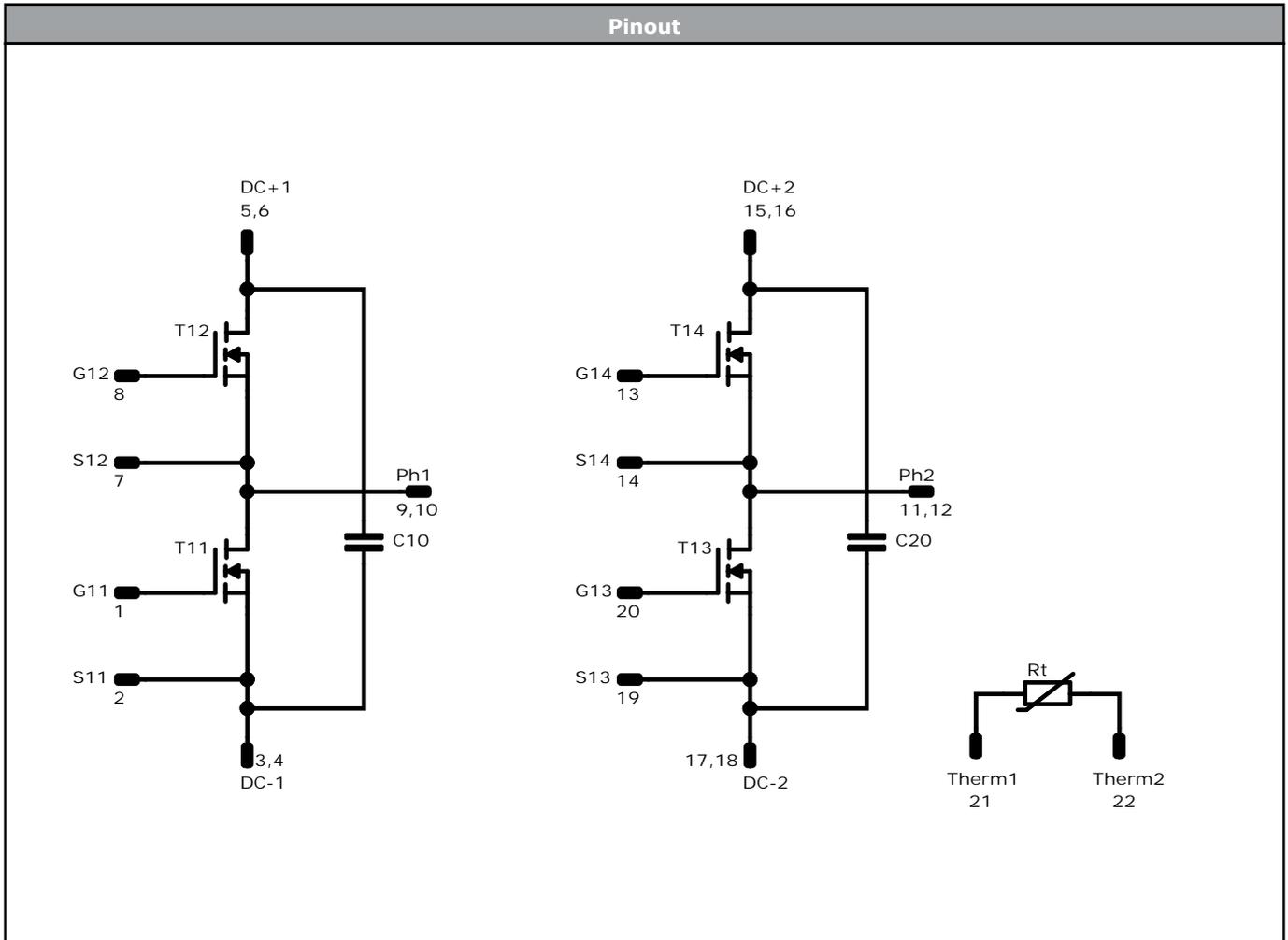
figure 28. FWD

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})





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Identification					
ID	Component	Voltage	Current	Function	Comment
T11, T12, T13, T14	MOSFET	1200 V	75 mΩ	Half-Bridge Switch	
C10, C20	Capacitor	1000 V		Capacitor (DC)	
Rt	Thermistor			Thermistor	



Vincotech

Packaging instruction				
Standard packaging quantity (SPQ) 135	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for <i>flow 0</i> packages see vincotech.com website.

Package data
Package data for <i>flow 0</i> packages see vincotech.com website.

Vincotech thermistor reference
See Vincotech thermistor reference table at vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
10-PZ124PA075ME03-L627F28Y-D1-14	12 Nov. 2020		

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.